## What is Claimed is:

1. A method of treating a substrate surface comprising copper or a copper alloy, the method comprising:

applying to the substrate surface a composition comprising:

one or more chelating agents;

one or more pH adjusting agents to produce a pH between about 3 and

6 about 11; and

deionized water; and then

applying a corrosion inhibitor solution.

- 1 2. The method according to claim 1, further comprising treating the substrate surface 2 with a corrosion inhibitor solution prior to treating the substrate surface with the 3 composition.
- 1 3. The method according to claim 2, wherein the corrosion inhibitor solution 2 comprises between about 0.01 wt.% and about 0.50 wt.% corrosion inhibitor and deionized water.
- 1 4. The method according to claim 3, wherein the corrosion inhibitor is selected from the group of benzotriazole, 5-methyl-1-benzotriazole, and combinations thereof.
- 1 5. The method according to claim 5, wherein the one or more chelating agents comprise an acid, a base, or a combination thereof.
  - 6. The method according to claim 5, wherein the one or more chelating agents comprise an acid having a concentration of up to about 40 wt.% of the composition.
- 1 7. The method according to claim 6, wherein the acid is a carboxylic acid having one or more acid groups.
- 1 8. The method according to claim 7, wherein the acid is selected from the group of acetic acid, citric acid, maleic acid, and combinations thereof.

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- 9. The method according to claim 1, wherein the one or more chelating agents comprise a base having a concentration up to about 5 wt.% of the composition.
- 1 10. The method according to claim 1, wherein the base comprises between about 0.5
- wt.% and about 3 wt.% of the composition.
- 1 11. The method according to claim 9, wherein the base is selected from the group of
- 2 ammonium hydroxide, ammonium hydroxide derivatives, amines, and combinations
- 3 thereof.
- 1 12. The method according to claim 1, wherein the composition further comprises a
- 2 corrosion inhibitor.
- 1 13. The method according to claim 12, wherein the corrosion inhibitor comprises
- between about 0.01 wt.% and about 0.50 wt.% of the composition.
- 1 14. The method according to claim 12, wherein the corrosion inhibitor is selected from
- 2 the group of benzotriazole, 5-methyl-1-benzotriazole, and combinations thereof.
- 1 15. The method according to claim 1, wherein the composition comprises up to about
- 2 40 wt.% citric acid, up to about 5 wt.% ammonium hydroxide, the remainder deionized
- 3 water.
- 1 16. The method according to claim 1, wherein the composition has a pH between about
- 4 and about 5 and comprises between about 5 wt.% and about 30 wt.% citric acid, between
- 3 about 0.5 wt.% and about 3.0 wt.% ammonium hydroxide.
- 1 17. The method according to claim 2, wherein the corrosion inhibitor solution is
- 2 applied prior to treating the substrate surface with the composition for between about 3
- 3 and about 10 seconds.

- 1 18. The method according to claim 1, wherein the composition is applied between
- 2 about 10 and about 20 seconds.
- 1 19. The method according to claim 1, wherein the composition further comprises a
- 2 reducing agent.
- 1 20. The method according to claim 19, wherein the reducing agent comprises between
- 2 about 0.01 wt.% and about 20 wt.% of the composition.
- 1 21. The method according to claim 19, wherein the reducing agent is selected from the
- 2 group of hydroxylamine, glucose, sulfothionate, potassium iodide, and combinations
- 3 thereof.

- 1 22. The method according to claim 1, wherein the corrosion inhibitor solution
- 2 comprises between about 0.01 wt.% and about 0.50 wt.% corrosion inhibitor and
- 3 deionized water.
- 1 23. The method according to claim 22, wherein the corrosion inhibitor is selected from
- 2 the group of benzotriazole, 5-methyl-1-benzotriazole, and combinations thereof.
- 1 24. The method according to claim 22, wherein the corrosion inhibitor solution is
- 2 applied between about 3 and about 10 seconds.
- 1 25. The method according to claim 1, wherein the one or more pH adjusting agents are
- 2 selected from the group of a non-oxidating inorganic acid, a non-oxidating organic acid, a
- 3 non-oxidating inorganic base, a non-oxidating organic base, and combinations thereof.
- 1 26. The method according to claim 1, wherein the one or more pH adjusting agents
- 2 comprise an acidic chelating agent, a basic chelating agent or a combination thereof.
- 1 27. A method of planarizing a substrate surface containing:



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- an dielectric layer having an upper surface and at least one opening;
- a barrier layer lining the opening and the upper surface of the dielectric layer; and
- 4 copper or a copper alloy filling the opening and on the dielectric layer;
  - the method comprising:

removing the copper or copper alloy layer and the barrier leaving an exposed substrate surface comprising copper or copper alloy in the opening; and

treating the exposed substrate surface comprising copper or the copper alloy by

- 9 applying thereto a composition comprising one or more chelating agents, one or more pH
- adjusting agents to produce a pH between about 3 and about 11, and deionized water;
- and then applying a corrosion inhibitor solution..
- 1 28. The method according to claim 27, further comprising removing the barrier layer
- 2 after removing the copper or copper alloy layer and prior to chemically treating the
- 3 exposed substrate surface.
- 1 29. The method according to claim 27, wherein removing the copper or the copper
  - alloy layer comprises chemical-mechanical polishing (CMP) the copper or the copper
- 3 alloy layer.
- 1 30. The method according to claim 29, wherein the method comprises:
- 2 removing the copper or copper alloy layer and stopping on the barrier layer;
- 3 removing the barrier layer and leaving the exposed substrate surface comprising
- 4 copper or copper alloy features.
- 1 31. The method according to claim 27, wherein:
- 2 the dielectric layer comprises a silicon oxide; and
- 3 the barrier layer comprises tantalum (Ta) or tantalum nitride (TaN).
- 1 32. The method according to claim 27, wherein the method comprises chemically
- 2 treating the exposed substrate surface comprising copper or the copper alloy layer to

- 3 remove a portion of the substrate surface of the copper or copper alloy or to remove
- 4 corrosion stains from the copper or copper alloy substrate surface.
- 1 33. The method according to claim 32, wherein the method comprises chemically
- 2 removing up to about 50Å from the exposed substrate surface comprising copper or the
- 3 copper alloy.
- 1 34. The method according to claim 27, further comprising treating the substrate surface
- with a corrosion inhibitor solution prior to applying the composition.
- 1 35. The method according to claim 27, wherein the composition comprises deionized
- water, citric acid and ammonium hydroxide.
- 1 36. The method according to claim 27, wherein the method comprises:
- 2 mounting the substrate on a carrier in a CMP apparatus;
- 3 CMP the substrate using a polishing pad;
- 4 performing the initial treating step;
- 5 applying the composition; and
- 6 applying the corrosion inhibitor solution while separating the substrate from the
- 7 polishing pad.

- 1 37. The method according to claim 34, wherein the corrosion inhibitor solution
- 2 comprises between about 0.01 wt.% and about 0.50 wt.% corrosion inhibitor and
- 3 deionized water.
- 1 38. The method according to claim 37, wherein the corrosion inhibitor is selected from
- 2 the group of benzotriazole, 5-methyl-1-benzotriazole, and combinations thereof.
- 1 39. The method according to claim 27, wherein the one or more chelating agents
- 2 comprise an acid, a base, or a combination thereof.



- 40. The method according to claim 39, wherein the one or more chelating agents comprise an acid having a concentration of up to about 40 wt.% of the composition.
- 1 41. The method according to claim 40, wherein the acid is a carboxylic acid having
- 2 one or more acid groups.
- 1 42. The method according to claim 41, wherein the acid is selected from the group of
- 2 acetic acid, citric acid, maleic acid, and combinations thereof.
- 1 43. The method according to claim 27, wherein the base comprises up to about 5 wt.%
- 2 of the composition.
- 1 44. The method according to claim 43, wherein the base comprises between about 0.5
- wt.% and about 3 wt.% of the composition.
- 1 45. The method according to claim 43, wherein the base is selected from the group of
- 2 ammonium hydroxide, ammonium hydroxide derivatives, amines, and combinations
- 3 thereof.
- 1 46. The method according to claim 27, wherein the composition further comprises a
- 2 corrosion inhibitor.
- 1 47. The method according to claim 46, wherein the corrosion inhibitor comprises
- between about 0.01 wt.% and about 0.50 wt.% of the composition.
- 1 48. The method according to claim 46, wherein the corrosion inhibitor is selected from
- 2 the group of benzotriazole, 5-methyl-1-benzotriazole, and combinations thereof.
- 1 49. The method according to claim 27, wherein the composition comprises up to about
- 2 40 wt.% citric acid, up to about 5 wt.% ammonium hydroxide, and the remainder of the
- 3 composition comprises deionized water.

- 1 50. The method according to claim 49, wherein the composition has a pH between
- 2 about 4 and about 5 and comprises between about 5 wt.% and about 30 wt.% citric acid,
- 3 between about 0.5 and about 3.0 wt.% ammonium hydroxide.
- 1 51. The method according to claim 34, wherein the corrosion inhibitor solution is
- 2 applied between about 3 and about 10 seconds prior to treating the substrate surface with
- 3 the composition.
- 1 52. The method according to claim 27, wherein the composition is applied between
- 2 about 10 and about 20 seconds.
- 1 53. The method according to claim 34, wherein the corrosion inhibitor solution
- 2 comprises between about 0.01 wt.% and about 0.50 wt.% corrosion inhibitor and
- 3 deionized water.
- 1 54. The method according to claim 34, wherein the corrosion inhibitor is selected from
- 2 the group of benzotriazole, 5-methyl-1-benzotriazole, and combinations thereof.
- 1 55. The method according to claim 27, wherein the corrosion inhibitor solution is
- 2 applied between about 3 and about 10 seconds.
- 1 56. The method according to claim 27, wherein the pH adjusting agent is selected from
- 2 the group of a non-oxidating inorganic acid, a non-oxidating organic acid, a non-oxidating
- 3 inorganic base, a non-oxidating organic base, and combinations thereof.
- 1 57. The method according to claim 27, wherein the one or more pH adjusting agents
- 2 comprise an acidic chelating agent, a basic chelating agent or a combination thereof.
- 1 58. The method according to claim 27, wherein the composition further comprises a
- 2 reducing agent.

- 1 59. The method according to claim 58, wherein the reducing agent comprises between
- 2 about 0.01 wt.% and about 20 wt.% of the composition.
- 1 60. The method according to claim 58, wherein the reducing agent is selected from the
- 2 group of hydroxylamine, glucose, sulfothionate, potassium iodide, and combinations
- 3 thereof.